

N-Channel Enhancement Mode MOSFET

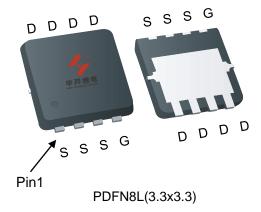
Feature

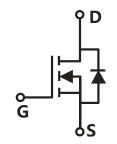
- 150V/18A
 R_{DS(ON)}= 57mΩ(typ.) @VGS = 10V
- 100% Avalanche Tested
- 100% DVDS
- Reliable and Rugged
- Halogen Free and Green Devices Available (RoHS Compliant)

Applications

- Electrical machinery
- Synchronous Rectification
- DC-DC
- Motor control

Pin Description





Single N-Channel MOSFET

Ordering and Marking Information

Package Code

HYG

C1: PDFN8L(3.3x3.3)

580N15NS

XYMXXXXX

Date Code

XYMXXXXXX

Note: HUAYI halogen free products contain molding compounds and 100% matter tin plate Termi-Nation finish; which are fully compliant with RoHS. HUAYI halogen free products meet or exceed the halogen free require-ments of IPC/JEDEC J-STD-020 for MSL classification at halogen free peak reflow temperature. HUAYI defines "Green" to mean halogen free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this pr-oduct and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit		
Common Rat	tings (Tc=25°C Unless Otherwise Noted)				
VDSS	Drain-Source Voltage		150	V	
Vgss	Gate-Source Voltage		±20	V	
TJ	Junction Temperature Range		55. 475	°C	
Tstg	Storage Temperature Range		-55 to 175	°C	
Is	Source Current-Continuous(Body Diode)	Tc=25°C	18	А	
Mounted on	Mounted on Large Heat Sink				
Ідм	Pulsed Drain Current *	Tc=25°C	55	А	
1	Outing a Paris Count	Tc=25°C	18	А	
lo	Continuous Drain Current	Tc=100°C	12	А	
	M	Tc=25°C	43	W	
Po	Maximum Power Dissipation	Tc=100°C	21	W	
R₀c	Thermal Resistance, Junction-to-Case		3.5	°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient **		100	°C/W	
Eas	Single Pulsed-Avalanche Energy ***	L=0.3mH	48	mJ	

Note:

- * Repetitive rating; pulse width limited by max.junction temperature.
- ** Surface mounted on 1in2 FR-4 board.
- *** Limited by TJmax , starting TJ=25°C, L = 0.3mH, Rg= 25Ω , Vgs =10V.

Electrical Characteristics(Tc =25°C Unless Otherwise Noted)

Ol	Paramatan.	Took Conditions	HYG580N15NS1		1114	
Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Static Cha	racteristics	•				
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =250μA	150	-	-	V
I	Drain to Course Leakers Current	Vps=150V,Vgs=0V	-	-	1	μA
IDSS Drain-to-Source Leakage Current	TJ=125°C	-	-	50	μA	
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250µA	2	3.2	4	V
lgss	Gate-Source Leakage Current	Vgs=±20V,Vps=0V	-	-	±100	nA
RDS(ON)	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =10A	-	57	73	mΩ
Diode Characteristics						
VsD	Diode Forward Voltage	Isp=10A,Vgs=0V	-	0.89	1.2	V
trr	Reverse Recovery Time	lon-104 dlon/dt-1004/up	-	61	-	ns
Qrr	Reverse Recovery Charge	- IsD=10A,dIsD/dt=100A/μs	-	122	-	nC



Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

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Symbol	Parameter	Test Conditions	Min	Тур.	Max	Unit
Dynamic (Dynamic Characteristics					
Rg	Gate Resistance	V _{GS} =0V,V _{DS} =0V,F=1MHz	-	4.1	-	Ω
Ciss	Input Capacitance	Vgs=0V,	-	531	-	
Coss	Output Capacitance	V _{DS} =25V,	-	287	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1MHz	-	16	-	
td(ON)	Turn-on Delay Time		-	3.6	-	
Tr	Turn-on Rise Time	$V_{DD}=75V,R_{G}=4\Omega,$	-	7.2	-	
td(OFF)	Turn-off Delay Time	Ips=10A,Vgs=10V	-	14	-	ns
Tf	Turn-off Fall Time		-	20	-	
Gate Char	Gate Charge Characteristics					
Qg	Total Gate Charge(V _{GS} =10V)		-	8.4	-	
Qgs	Gate-Source Charge	V -120V I -10A	-	3.4	-	nC
Qgd	Gate-Drain Charge	V_{DS} =120V, I_{DS} =10A	-	1.8	-	
V _{plateau}	Gate plateau voltage		-	5.5	-	V

Note: *Pulse test, pulse width ≤ 300 us, duty cycle $\leq 2\%$



Typical Operating Characteristics

Figure 1: Power Dissipation

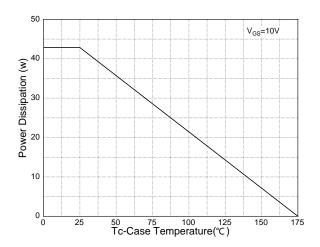


Figure 3: Safe Operation Area

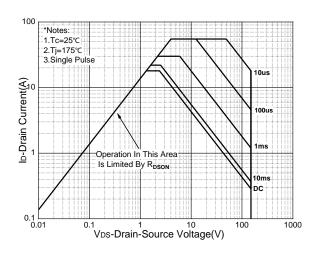


Figure 5: Output Characteristics

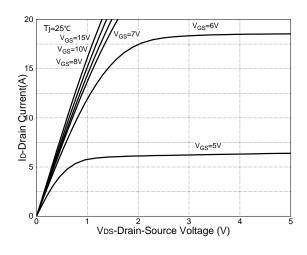


Figure 2: Drain Current

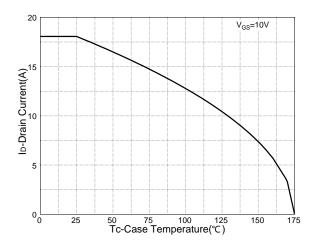


Figure 4: Thermal Transient Impedance

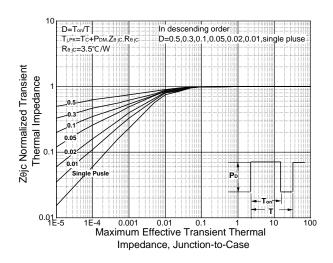
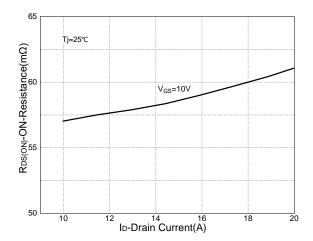


Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature

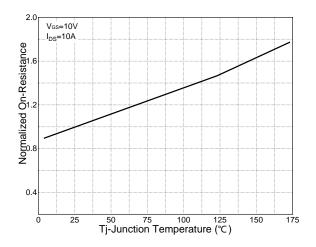


Figure 8: Source-Drain Diode Forward

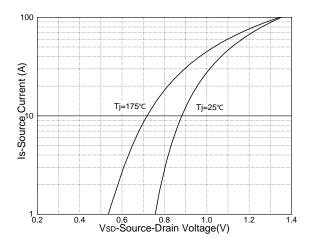


Figure 9: Capacitance Characteristics

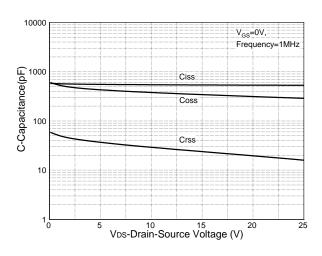
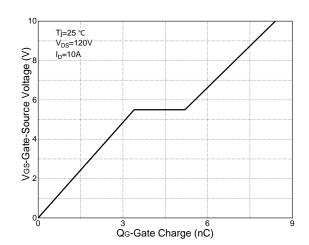
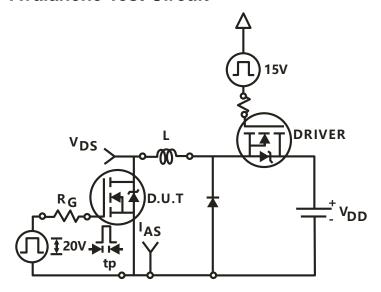


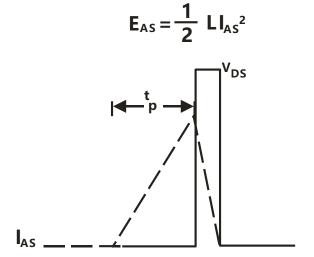
Figure 10: Gate Charge Characteristics



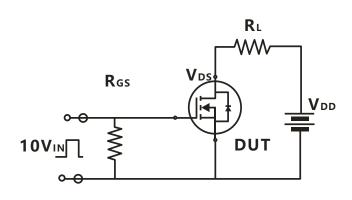


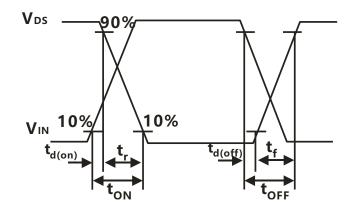
Avalanche Test Circuit



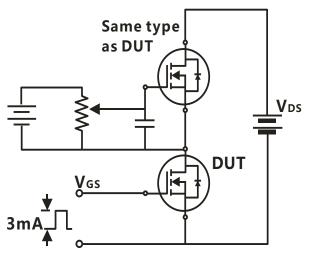


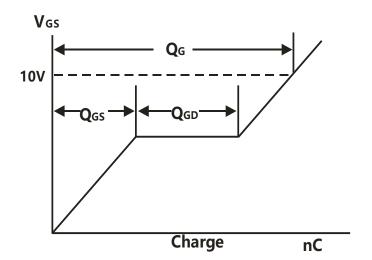
Switching Time Test Circuit





Gate Charge Test Circuit





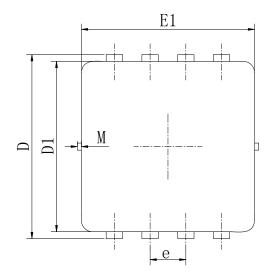


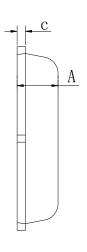
Device Per Unit

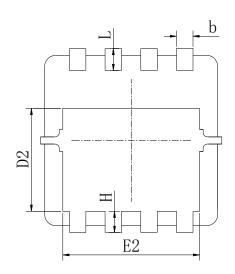
Package Type	Unit	Quantity
PDFN8L(3.3x3.3)	Reel	6500

Package Information

PDFN8L(3.3x3.3)



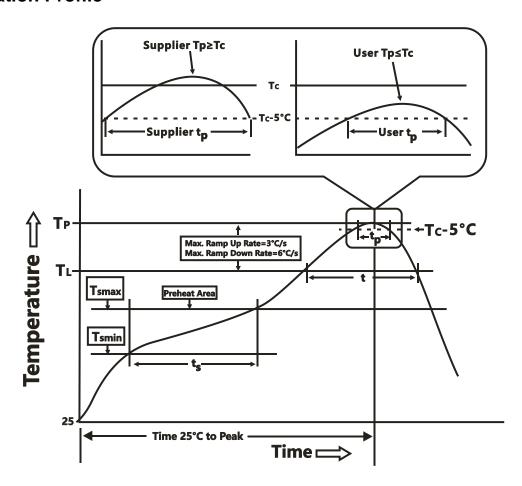




COMMON DIMENSIONS				
SYMBOL	mm			
STIVIBUL	MIN	NOM	MAX	
Α	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.78	1.88	1.98	
E1	3.10	3.20	3.30	
E2	2.44	2.54	2.64	
е	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
M	\	\	0.10	
*Not specified				



Classification Profile



Classification Reflow Profiles

Sn-Pb Eutectic Assembly	Pb-Free Assembly			
Preheat & Soak				
100 °C	150 °C			
150 °C	200 °C			
60-120 seconds	60-120 seconds			
2 °C/second may	3°C/second max.			
5 C/second max.				
183 °C	217 °C			
60-150 seconds	60-150 seconds			
See Classification Temp in table 1	SeeClassification Tempin table 2			
See Classification Temp in table 1				
20** accords	20** 000000			
20 seconds	30** seconds			
6 °C/second max.	6 °C/second max.			
6 minutes max.	8 minutes max.			
	Preheat & Soak 100 °C 150 °C 60-120 seconds 3 °C/second max. 183 °C 60-150 seconds See Classification Temp in table 1 20** seconds 6 °C/second max.			

^{*}Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum.

HYG580N15NS1C1



Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package Thickness	Volume mm³ <350	Volume mm³ ≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm ³	Volume mm ³	Volume mm³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500/1000 Hrs, Bias @ 150°C
HTGB	JESD-22, A108	168 /500/1000 Hrs, V _{gs} 100% @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
тст	JESD-22, A104	250/500/1000 Cycles, -55°C~150°C

Customer Service

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